Notice of References Cited

| Application/Control No. 09/519,766 | Reexamination | Applicant(s)/Patent Under Reexamination HAYASHI ET AL. | |
|------------------------------------|---------------|--|--|
| Examiner | Art Unit | | |
| Maikhanh Nguyen | 2176 | Page 1 of 1 | |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------------|----------------|
| | Α | US-6,564,254 B1 | 05-2003 | Shoji et al. | 709/217 |
| | В | US-6,460,058 B2 | 10-2002 | Koppolu et al. | 345/738 |
| | С | US-6,275,862 B1 | 08-2001 | Sharma et al. | 709/245 |
| | D | US-6,211,871 B1 | 04-2001 | Himmel et al. | 345/744 |
| | Ε | US-6,208,995 B1 | 03-2001 | Himmel et al. | 707/104.1 |
| | F | US-6,119,135 A | 09-2000 | Helfman, Jonathan Isaac | 715/513 |
| | G | US-6,049,812 A | 04-2000 | Bertram et al. | 715/516 |
| | Н | US-6,023,701 A | 02-2000 | Malik et al. | 707/10 |
| | ı | US- | | | |
| | J | US- | | | |
| | К | US- | | | |
| | L | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | , | | | |
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| | S | | | | | |
| | Т | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | v | |
| | w | |
| | x | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYYY format are publication dates. Classifications may be US or foreign.